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Application/Control No.	Applicant(s)/Patent under Reexamination
10/712,430	HANSEN ET AL.
Examiner	Art Unit
Fric Coleman	2182

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Searched East US Pat fiile US PG Pub file EPO file	2/28/2006	EQ